

<b>Notice of References Cited</b>	Application/Control No. 09/940,629		Applicant(s)/Patent Under Reexamination TAKAHASHI, TOSHIYA	
	Examiner Gelek Topgyal		Art Unit 2621	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,614,988	09-2003	Sampsell, Jeffrey Brian	386/95
*	B	US-6,538,698	03-2003	Anderson, Eric C.	348/333.05
*	C	US-5,561,531	10-1996	Funazaki, Fumihiko	386/95
*	D	US-5,903,309	05-1999	Anderson, Eric C.	348/333.02
*	E	US-5,515,101	05-1996	Yoshida, Tadahiro	348/239
*	F	US-6,629,104	09-2003	Parulski et al.	707/102
*	G	US-6,686,970	02-2004	Windle, John Richard	348/584
*	H	US-6,788,346	09-2004	Ito et al.	348/372
*	I	US-2004/0208482	10-2004	Suga et al.	386/095
*	J	US-2005/0053352	03-2005	McKain et al.	386/046
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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